

# Chapter (2)

# **Energy Band-gap Theory**

# **Scientific Terms and Formulas to Remember**

Generally, the conduction in the crystal (such as semiconductors materials) depends on the number of charge carriers. The number of charge carrier that contributes to the conduction process is the function of the number of available energy or quantum states. The density of these allowed energy state is called the density of state function. This helps to calculate the hole and electron concentration.

### **Important Scientific Terms:**

 $n_i^2 = n_o P_o$ . Intrinsic carrier concentration

E<sub>Fi</sub>: intrinsic Fermi energy

 $N_{\rm d}$  or  $N_{\rm D}$ : It is the donor concentration, for an n-type material at equilibrium:

$$n \approx N_d cm^{-3}$$

where  $n_0$  is the number of conducting electrons (electron concentration)

 $N_{\rm a}$  or  $N_{\rm A}$ : It is the acceptor concentration, for a p-type material at equilibrium:

$$P_o \approx N_a cm^{-3}$$

where  $P_o$  is the hole concentration.

 $N_{\rm c}$  : It is called the effective density of energy states (or quantum states) in the conduction band.

 $N_{\rm v}$ : It is called the effective density of energy states (or quantum states) in the Valence band.





# **Important Formulas:**

Dr. Khaldoon N. Abbas

1. Band-gap Energy  $(E_g) = (E_c - E_v)$ 

$$\left|\mathbf{n_0} \ \mathbf{p_0} \right| = \mathbf{n_i^2} = \ \mathbf{N_c} \mathbf{N_v} \exp\left(\frac{-\mathbf{E_g}}{kT}\right)$$

- 2. Position of the fermi level in the n-type semiconductor in terms of  $N_c$  and  $n_0$  is given by  $E_c E_F = kT \ln \left( \frac{N_c}{n_c} \right)$
- 3. Position of the fermi level in the n-type semiconductor in terms of  $N_d$  and  $N_c$  is given by  $E_c E_F = kT \ln \left( \frac{N_c}{N_d} \right) \qquad \begin{bmatrix} \text{Since, in n-type semiconductor we have,} \\ N_d > n_i & \text{and} & n_0 \approx N_d \end{bmatrix}$
- 4. Position of the fermi level in the p-type semiconductor in terms of  $N_a$  and  $N_v$  is given by  $E_F E_v = kT \, ln \bigg( \frac{N_v}{N_a} \bigg)$
- Concentration of electrons in the conduction band in terms of  $n_i$  is given by  $n_0 = n_i \, exp \bigg( \frac{(E_F E_{Fi})}{kT} \bigg)$
- 6. Concentration of holes in the valence band in terms of  $n_i$  is given by  $p_0 = n_i \, exp \bigg( \frac{\text{--}(E_F \text{--}E_{Fi})}{kT} \bigg)$
- 7. Position of the fermi level in the n-type semiconductor in terms of  $n_o$  and  $n_i$  is given by  $E_F E_{Fi} = kT \ln\!\left(\frac{n_o}{n_i}\right)$
- 8. Position of the fermi level in the p-type semiconductor in terms of  $p_o$  and  $n_i$  is given by  $E_{Fi} E_F = kT \ln \left(\frac{p_o}{n_i}\right)$





ملاحظة/ عتد قرانتك للمصادر العلمية المختلفة المتعلقة بهذا الموضوع ممكن ان يكون هناك اختلاف بسيط فى استخدام الرموز العلمية او قيمة الثوابت من قبل المؤلفين لذلك انا تعمدت ان اضع رمزين بعض الاحيان مثلا electron concentration (n or  $n_0$ ) والتى تدل على نفس المعنى العلمي للمطلح المستخدم وهذا من اجل ان لا يحصل عند الطالب التباس اثناء القراءة .

These are examples presenting the relationship between doping, carrier concentrations and the Fermi energy level at equilibrium condition

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**Required Constants**: For silicon (Si) at T=300 K,  $n_i = 1.5 \times 10^{10}$  cm<sup>-3</sup>. The Boltzmann constant  $k_B = k = 8.61 \times 10^{-5}$  eV/K. Silicon band-gap energy  $E_g = 1.12$  eV.

**Q1**/ The electron concentration in Silicon (Si) at T = 300 K is  $n_o = 5 \times 10^4$  cm  $^{-3}$ ? (a) Determine hole concentration ( $P_o$ ). Is this n or p-type material? (b) Determine the position of the Fermi energy level ( $E_F$ ) with respect to the intrinsic Fermi energy level ( $E_{Fi}$ ). If  $n_i$  of (Si) is about  $1.5 \times 10^{10}$  cm $^{-3}$ 

Answer:

$$n_0 = 5 \times 10^4$$
 at  $T = 300 \text{ K}$ 

$$p_0 = \frac{n_i^2}{n_0} = \frac{\left(1.5 \times 10^{10}\right)^2}{5 \times 10^4} = 4.5 \times 10^{15} cm^{-3}$$

As  $p_0 > n_0$  the material is p-type semiconductor.

We know that

$$p_0 = n_i exp \left[ \frac{-(E_F - E_{Fi})}{kT} \right] \Rightarrow E_{Fi} - E_F = kT ln \left[ \frac{(p_0)}{n_i} \right]$$

$$E_{Fi}-E_{F} = 0.0259 \ln \left[ \frac{4.5 \times 10^{15}}{1.5 \times 10^{10}} \right] = 0.3266 \text{ eV}$$



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Q2/ The value of  $p_0$  in Silicon at T = 300 K is  $10^{15}$  cm<sup>-3</sup>. Determine  $E_C - E_F$  and  $n_0$ .

Answer 
$$p_0 = 10^{15} \text{ cm}^{-3}$$
 at  $T = 300 \text{ K}$   
 $p_0 = N_V \exp \left[ \frac{-(E_F - E_V)}{kT} \right]$   
 $= E_F - E_V = kT \ln \left[ \frac{N_V}{p_0} \right] = 0.0259 \ln \left[ \frac{1.04 \times 10^{19}}{10^{15}} \right] = 0.24 \text{ eV}$   
 $= E_C - E_F = 1.12 - 0.24 = 0.88 \text{ eV}$ 

$$n_{o} = ? (H.W.)$$

Q3 (A)/ Consider a silicon crystal at room temperature (300 K) doped with arsenic (As) atoms so that  $N_D = 6 \times 10^{16}$  cm<sup>-3</sup>. Find (1) the equilibrium electron concentration (n or  $n_o$ ), (2) hole concentration po, and (3) Fermi energy level (Ef or Ef) with respect to the intrinsic Fermi level (E<sub>fi</sub> or E<sub>i</sub>) and conduction band edge E<sub>C</sub>.

**Required Constants**: For silicon (Si) at T=300 K,  $n_i = 1.45 \times 10^{10}$  cm<sup>-3</sup>. The Boltzmann constant  $k = 8.61 \times 10^{-5} \text{ eV/K}$ . Silicon band-gap energy  $E_{g \text{ (si)}} = 1.12 \text{ eV}$ .

### Answer:

(1) This is an n-type material, as it is doped with donor atoms (N<sub>D</sub> or N<sub>d</sub>). Therefore:

$$(n \text{ or } n_0) = N_D = 6 \times 10^{16} \text{ cm}^{-3}$$
 (1)

(2) Then we can use the Law of Mass Action to find the (hole concentration):







$$p_0 = \frac{n_i^2}{n_0} = \frac{2.1 \times 10^{20}}{6 \times 10^{16}} = 3.5 \times 10^3 \text{ 1/cm}^3$$
 (2)

(3) To find the Fermi level with respect to the intrinsic Fermi level, we use the expression that links electron concentration to  $E_i$  and  $n_i$ :

$$n_0 = n_i \exp(\frac{E_F - E_i}{kT}) \Rightarrow (E_F - E_i) = kT \ln(\frac{n_0}{n_i})$$
(3)

At room temperature

Dr. Khaldoon N. Abbas

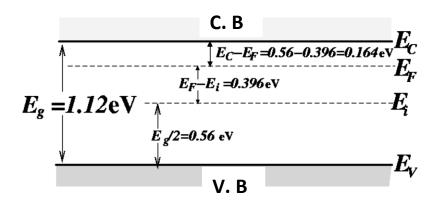
$$kT = 8.61 \times 10^{-5} \times 300 \approx 0.026 \text{ eV}$$
 (4)

We will be using this quantity often.

Then the separation of the Fermi level and intrinsic Fermi level is, from Eqn. 3:

$$(E_F - E_i) = 0.026 \ln(\frac{6 \times 10^{16}}{1.45 \times 10^{10}}) = 0.026 \times 15.24 = 0.396 \text{ eV}$$
  
 $\Rightarrow E_F = E_i + 0.396 \text{ eV}$  (5)

From drawing the band-gap energy (E<sub>g</sub>) diagram, we can then place the Fermi energy level (E<sub>F</sub>) in the correct place with respect to the intrinsic Fermi energy level (E<sub>i</sub> or E<sub>fi</sub>) (middle of band-gap energy  $(E_g)$ ) and also find its separation from the conduction band edge  $E_C$ .



### H. W (Homework)

Q3 (B) (H. W.) / Consider a silicon (Si) crystal at 300 K, with the Fermi energy level 0.15 eV above the valence band. What type is the material? Calculate the electron and hole concentrations?